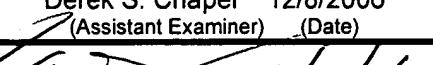


<b>Issue Classification</b> 	<b>Application/Control No.</b> 10/538,825	<b>Applicant(s)/Patent under Reexamination</b> YE, CHUN
	<b>Examiner</b> Derek S. Chapel	<b>Art Unit</b> 2872

ORIGINAL		INTERNATIONAL CLASSIFICATION						
CLASS	SUBCLASS	CLAIMED				NON-CLAIMED		
359	501	G	02	B	5	/30		/
CROSS REFERENCES					/			/
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)							
359	498	497				/		/
						/		/
						/		/
						/		/
						/		/
Derek S. Chapel 12/8/2006 (Assistant Examiner) (Date)		ARINEL LAVARIAS PRIMARY PATENT EXAMINER				Total Claims Allowed: 65		
 (Legal Instruments Examiner) (Date)		 (Primary Examiner) 12/11/06 (Date)				O.G. Print Claim(s)		O.G. Print Fig.
		6						11

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	1	30	31	60	61	91	
2	2	31	32	61	62	92	
3	3	32	33	62	63	93	
4	4	33	34	63	64	94	
5	5	34	35	64	65	95	
6	6	35	36	65	66	96	
7	7	36	37	67		97	
8	8	37	38	68		98	
9	9	38	39	69		99	
10	10	39	40	70		100	
11	11	40	41	71		101	
12	12	41	42	72		102	
13	13	42	43	73		103	
14	14	43	44	74		104	
15	15	44	45	75		105	
16	16	45	46	76		106	
17	17	46	47	77		107	
18	18	47	48	78		108	
	19	48	49	79		109	
19	20	49	50	80		110	
20	21	50	51	81		111	
21	22	51	52	82		112	
22	23	52	53	83		113	
23	24	53	54	84		114	
24	25	54	55	85		115	
25	26	55	56	86		116	
26	27	56	57	87		117	
27	28	57	58	88		118	
28	29	58	59	89		119	
29	30	59	60	90		120	